IL2239 - Course Project

Design of a SAR ADC

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Outline

Project Description

Design of a single-ended SAR ADC with the following specifications.

- Comparator clock frequency: 100 MHz
- SNDR $>$ 28 dB and SFDR $>$ 37 dB
- Technology: 150 nm CMOS
- Supply voltage: 1.8 V
- Input amplitude (V_{in}): 0.5 V_{pp}
- Input common-mode voltage: $0 \geq V_{\mathrm{in,cm}} \geq 1.8$ V
- Voltage reference: $V_{\mathrm{ref}} \leq 1.8$ V
- Switghing enegy below 30 pJ for $V_{\mathrm{in}} = 300$ mV

Roles and Responsibilities

Jordi:

- Comparator
- Successive Approximation Register
- Comparator Layout

Björn:

- Digital-to-Analog Converter
- Sample & Hold
- DAC Layout

Design Flow

We used a top-down design approach:

1. System-level design
2. Behavioral modeling using Verilog-AMS
3. Transistor level mddeling
4. Layout

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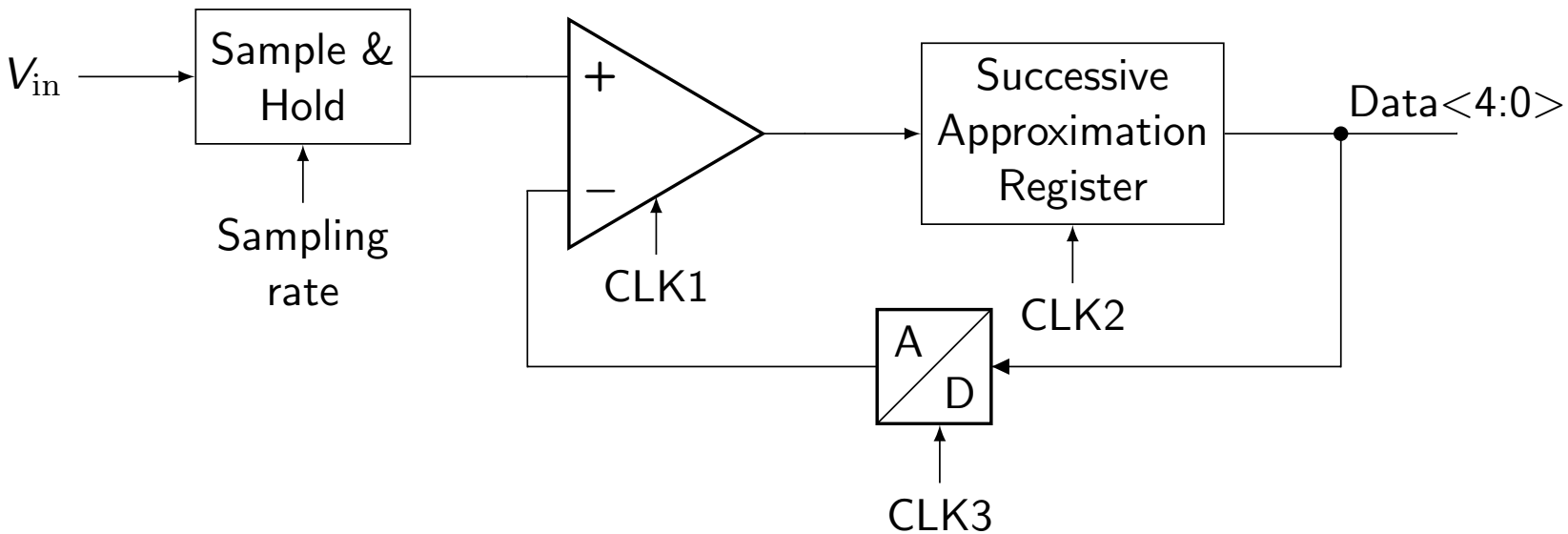
Co-simulations where also used to test individual blocks functionality

System-level Design I

Problem Statement

The basic block diagram of a SAR ADC looks as follows



System-level Design II

Proposed Solution

We choosed to use the following topology:

- Comparator: Strong ARM Latch
  - Reduced power consumption
  - Fast operation
  - Small area

System-level Design II

Proposed Solution

We choosed to use the following topology:

- Comparator: Strong ARM Latch
  - Reduced power consumption
  - Fast operation
  - Small area
- DAC: Charge redistribution weighted capacitors
  - Suitable for CMOS technology
  - Integrates the Sample & Hold

System-level Design III

Behavioral Modeling I

Comparator modeling:

```
1  always @(posedge CLK) begin
2      #5
3      outn = 0; outp = 0;
4  end
5  always @(negedge CLK) begin
6    if(V(inp) > V(inn)) begin
7      #50
8      outp = 1; outn = 0;
9    end else begin
10     #50
11     outp = 0; outn = 1;
12   end
13 end
```

Some delay was added to the behavioral model.

System-level Design III

Behavioral Modeling II

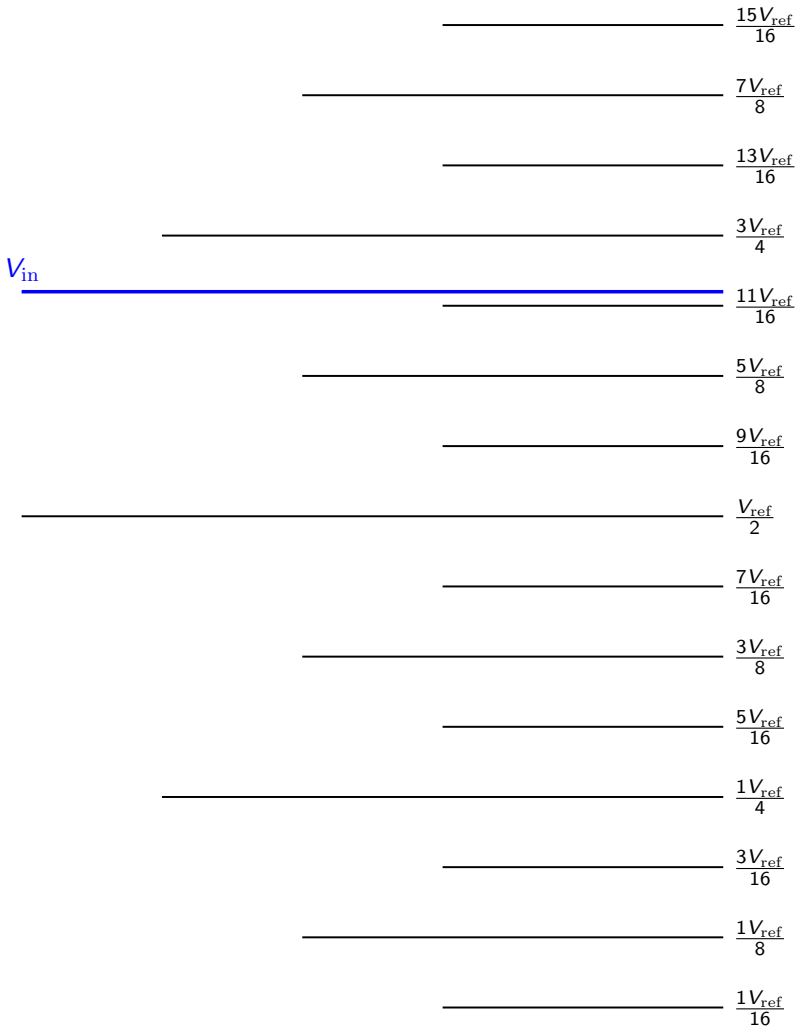
Digital-to-Analog Converter modeling:

```
1  analog begin
2    always @(posedge CLK) begin
3      for(i=0, i < 5, i++) begin
4        result += input[5-i] * Vref/5;
5      end
6      V(out) <+ transition(result, 1ns, 0.1ns, 0.1ns)
7    end
8  end
```

System-level Design III

Behavioral Modeling III

SAR Algorithm

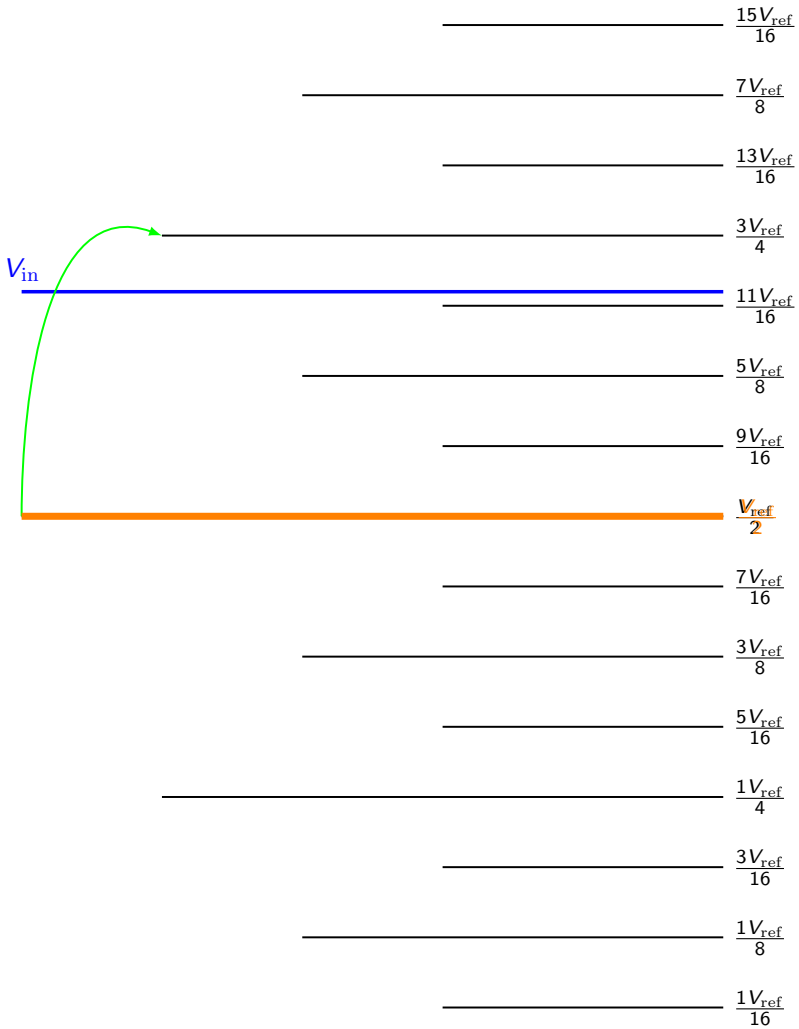


Assume $V_{\text{in}} = 0.7\,\text{V}$ and $V_{\text{ref}} = 1\,\text{V}$

System-level Design III

Behavioral Modeling III

SAR Algorithm



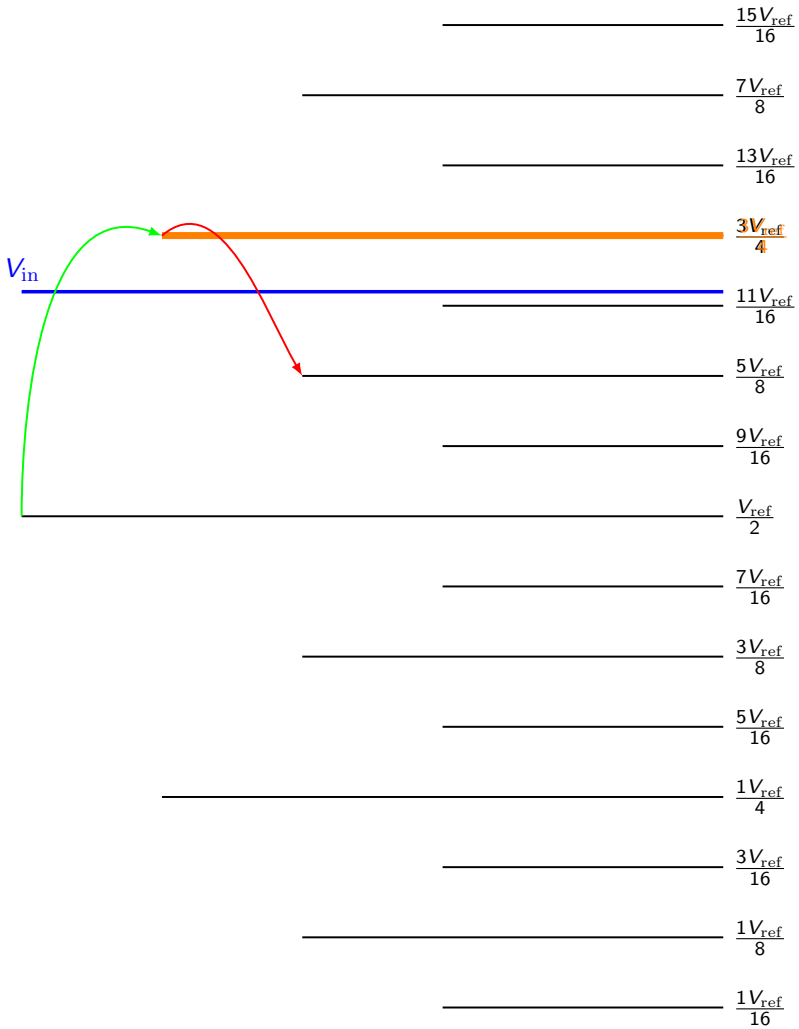
Assume $V_{\text{in}} = 0.7\,\text{V}$ and $V_{\text{ref}} = 1\,\text{V}$

1. $V_{\text{in}} \overset{?}{\geq} \frac{V_{\text{ref}}}{2}$ ✓

System-level Design III

Behavioral Modeling III

SAR Algorithm



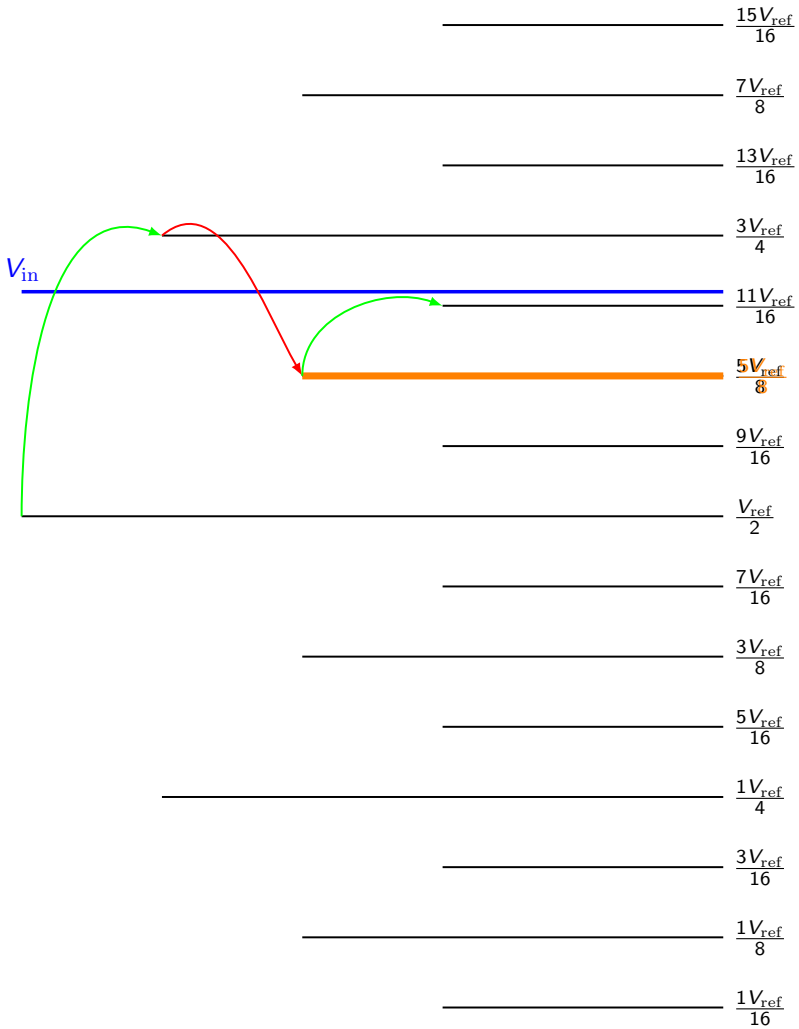
Assume $V_{in} = 0.7\,\mathrm{V}$ and $V_{ref} = 1\,\mathrm{V}$

1. $V_{in} \overset{?}{\geq} \frac{V_{ref}}{2}$ ✓
2. $V_{in} \overset{?}{\geq} \frac{3V_{ref}}{4}$ X

System-level Design III

Behavioral Modeling III

SAR Algorithm



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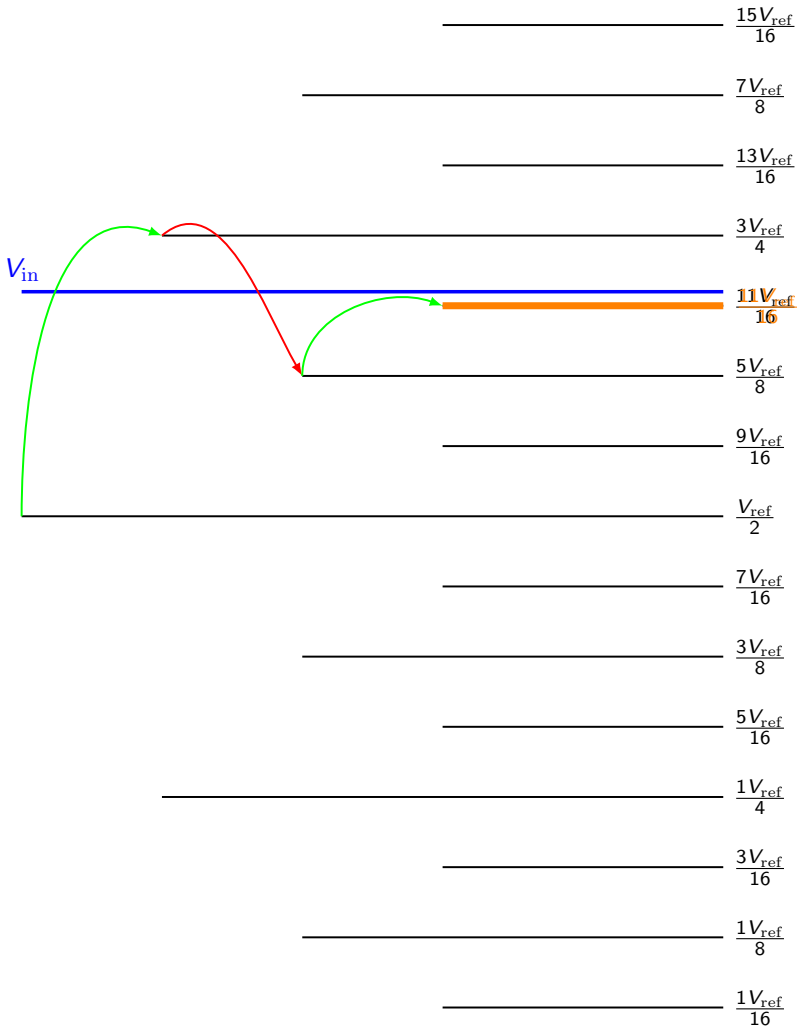
1. $V_{in} \overset{?}{\geq} \frac{V_{ref}}{2}$ ✓
2. $V_{in} \overset{?}{\geq} \frac{3V_{ref}}{4}$ X
3. $V_{in} \overset{?}{\geq} \frac{5V_{ref}}{8}$ ✓

System-level Design III

Behavioral Modeling III

SAR Algorithm



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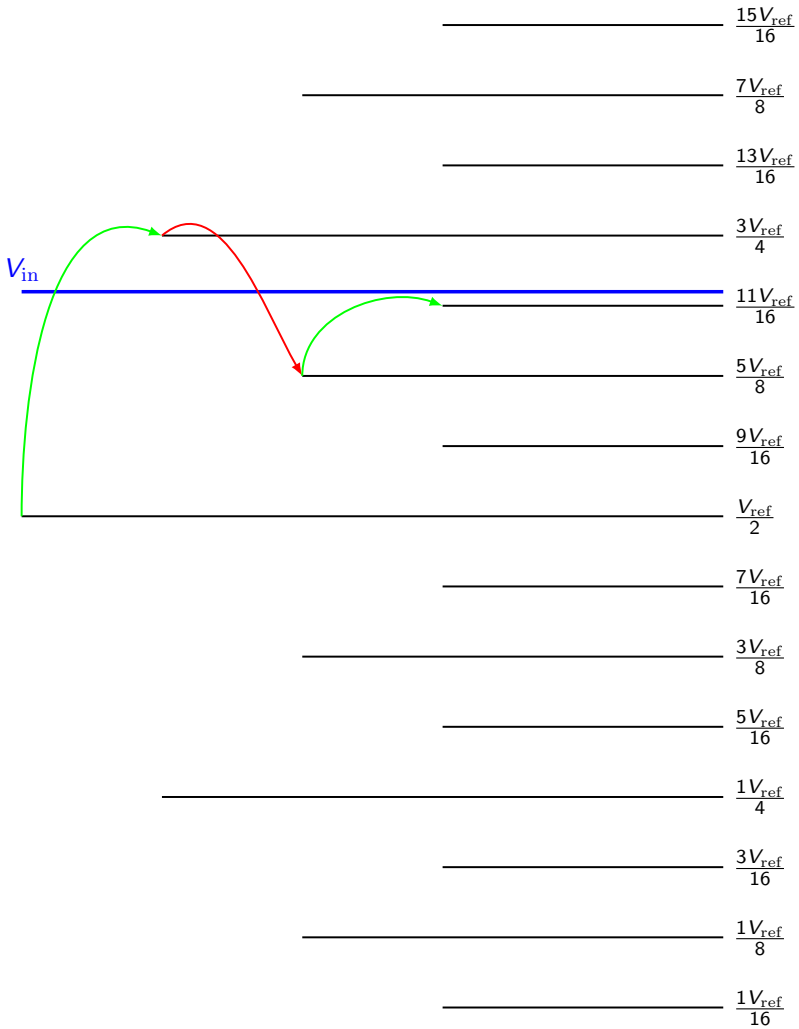
4. $V_{in} \overset{?}{\geq} \frac{11V_{ref}}{16}$ ✓

System-level Design III

Behavioral Modeling III

SAR Algorithm



Assume $V_{in} = 0.7\,V$ and $V_{ref} = 1\,V$

1. $V_{in} \overset{?}{\geq} \frac{V_{ref}}{2}$ ✓
2. $V_{in} \overset{?}{\geq} \frac{3V_{ref}}{4}$ X
3. $V_{in} \overset{?}{\geq} \frac{5V_{ref}}{8}$ ✓
4. $V_{in} \overset{?}{\geq} \frac{11V_{ref}}{16}$ ✓

Out = 0b1011 $(\frac{11V_{ref}}{16})$

Transistor-level Design I

Comparator

Transistor-level Design II

Digital-to-Analog Converter

Layout I

Comparator

- Use `itemizzze` a lot.
- Use `itemizzze` a lot.
- Use `itemizzze` a lot.
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Layout II

Digital-to-Analog Converter I

To ensure good matching we used:

- Common centroid technique

Layout II

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- Base unit of half the capacitance

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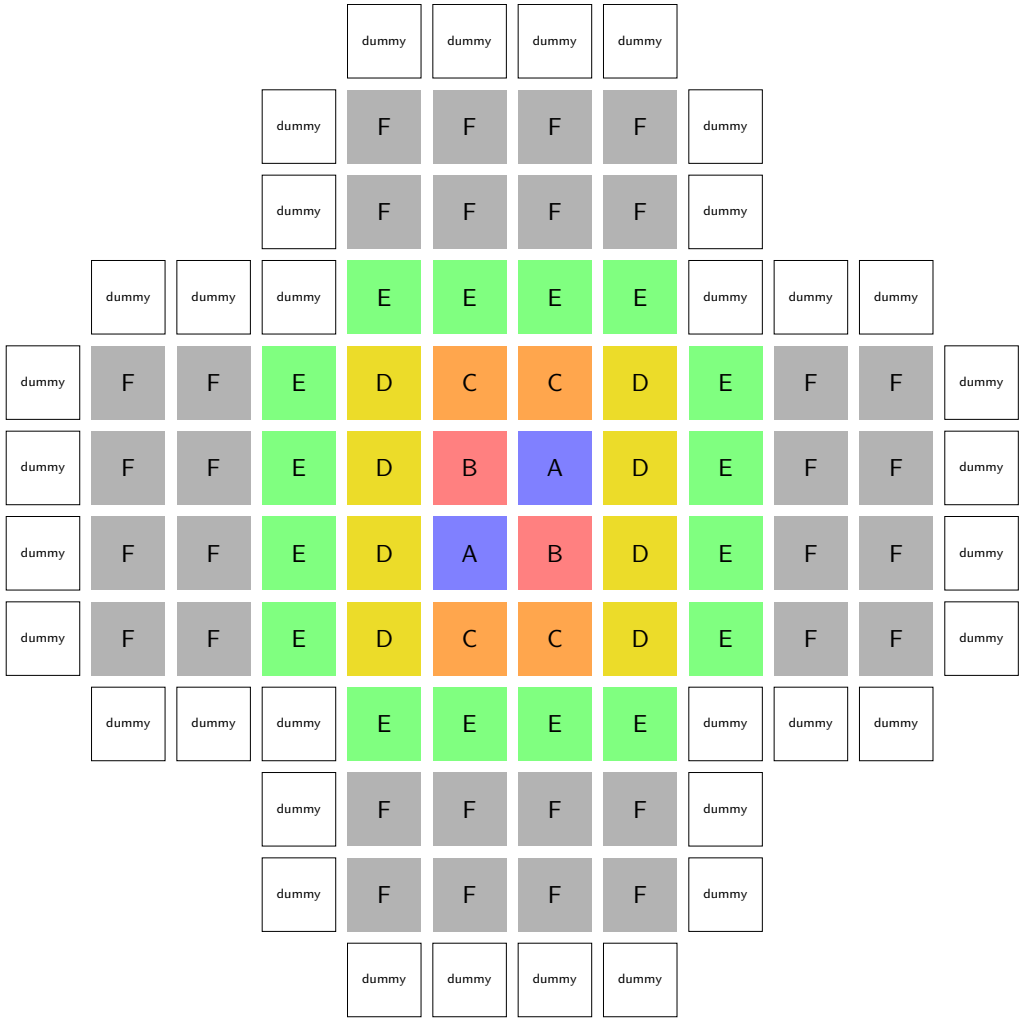
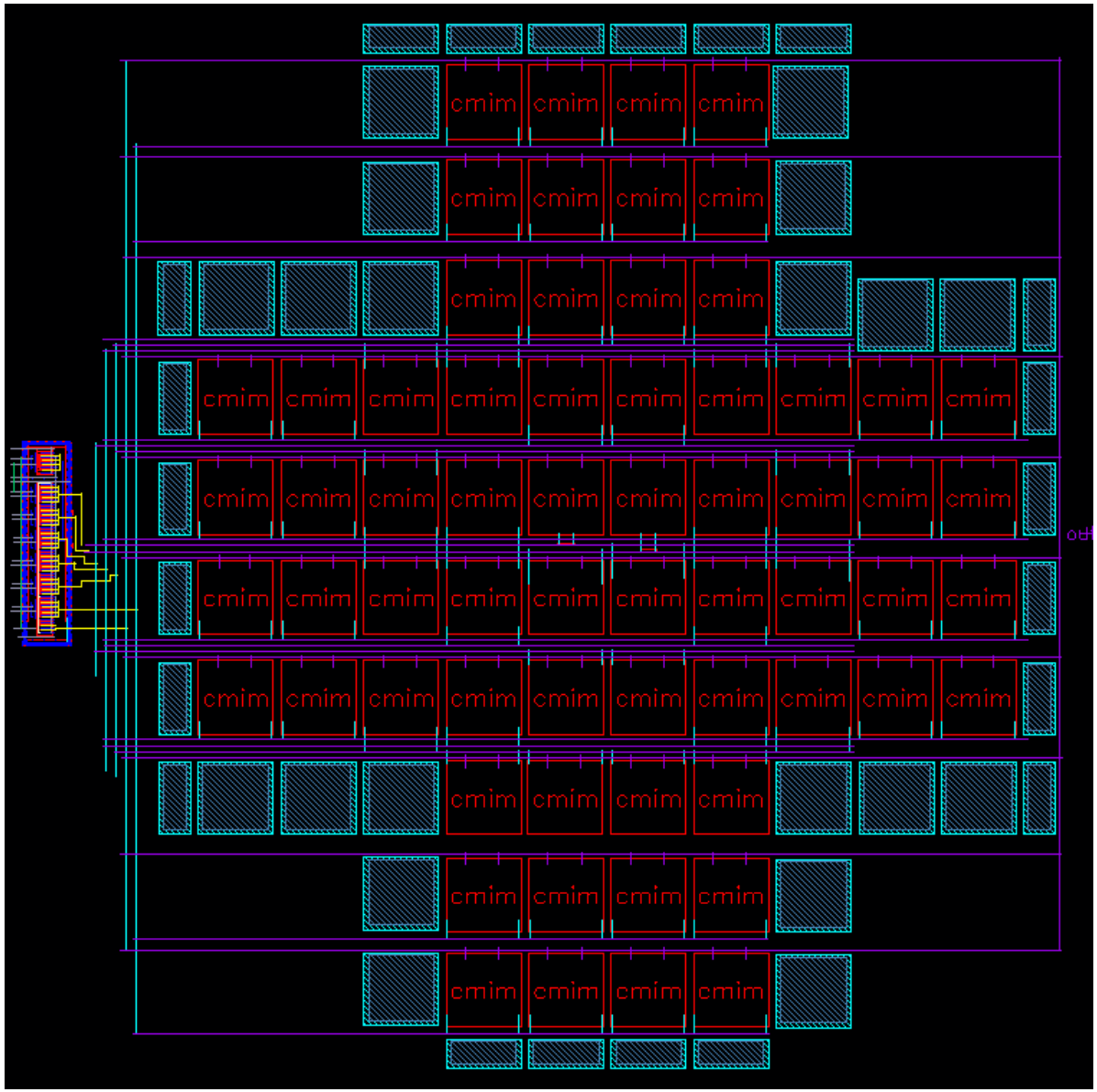


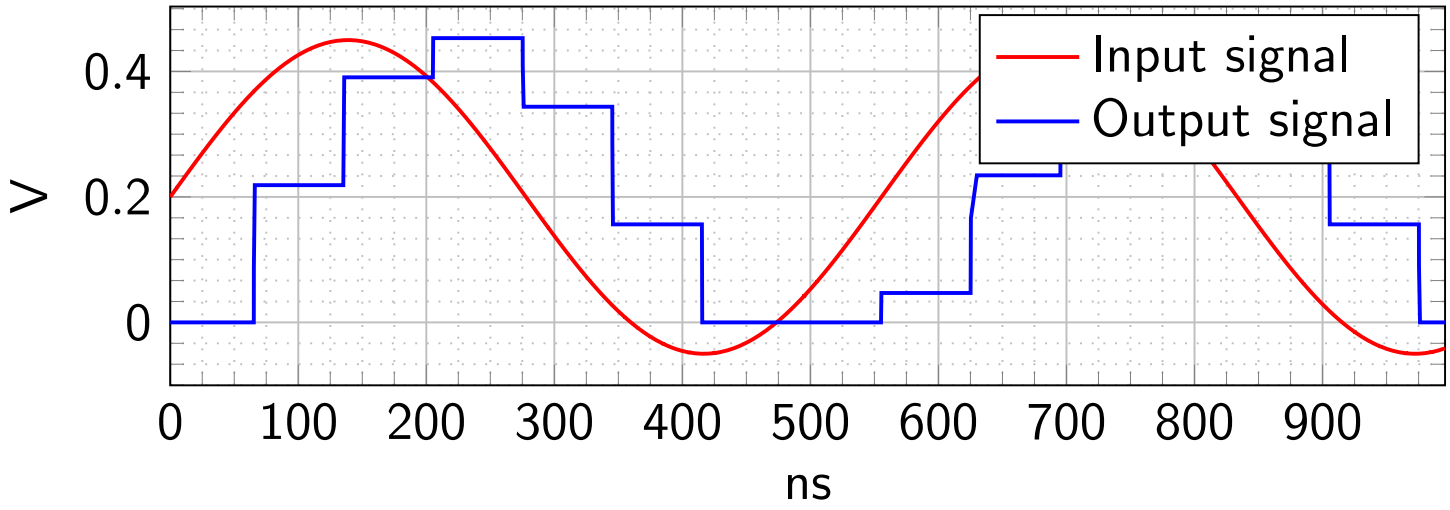
Layout II

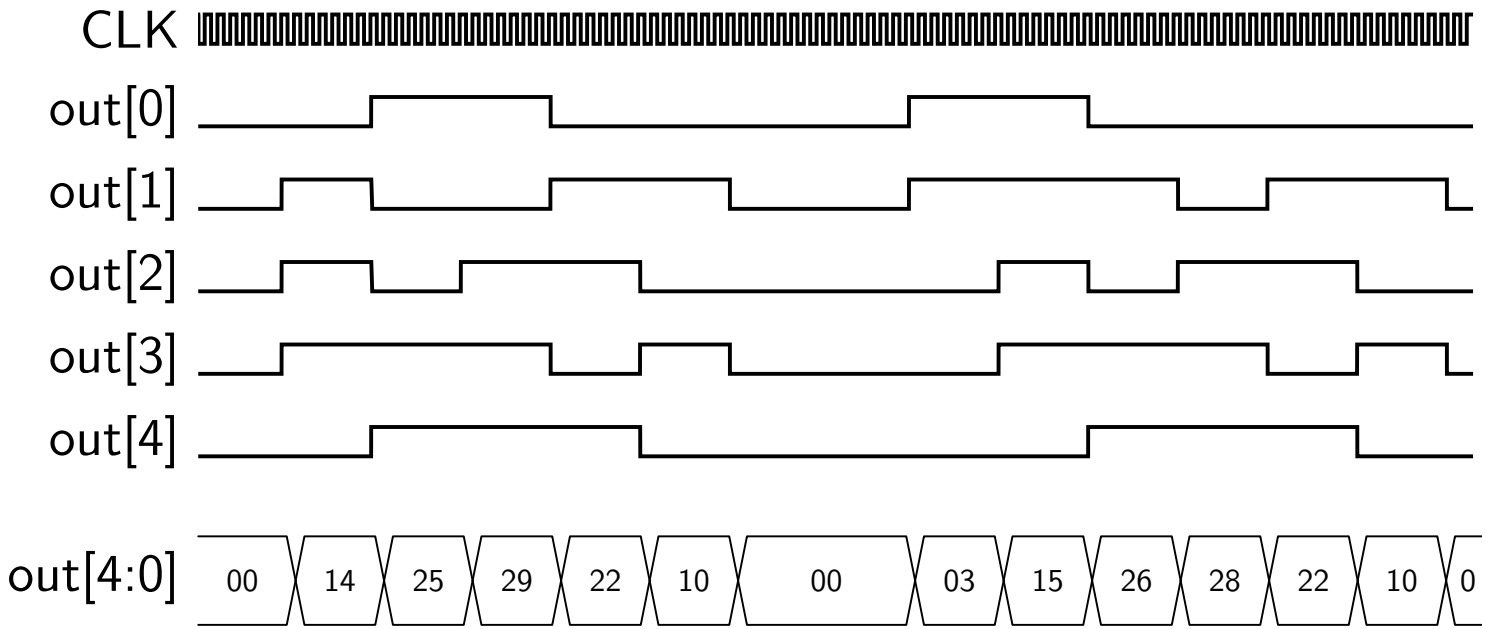
Digital-to-Analog Converter II



Simulations I

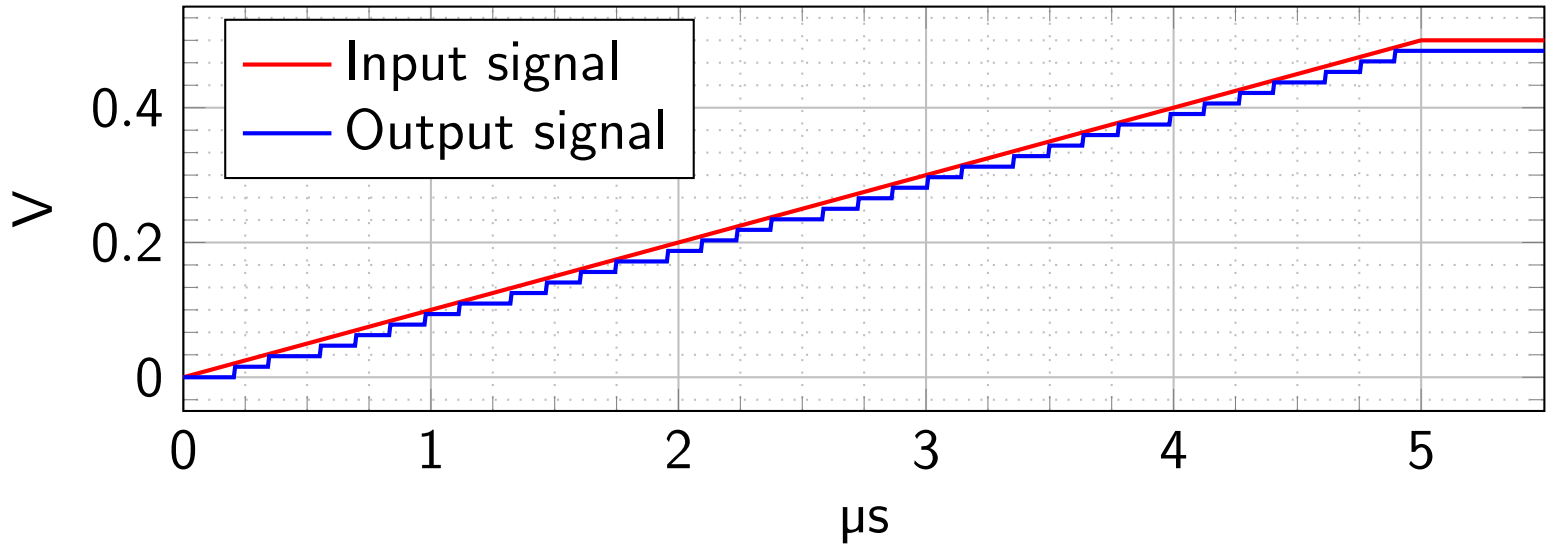
Sinusoidal Stimulus

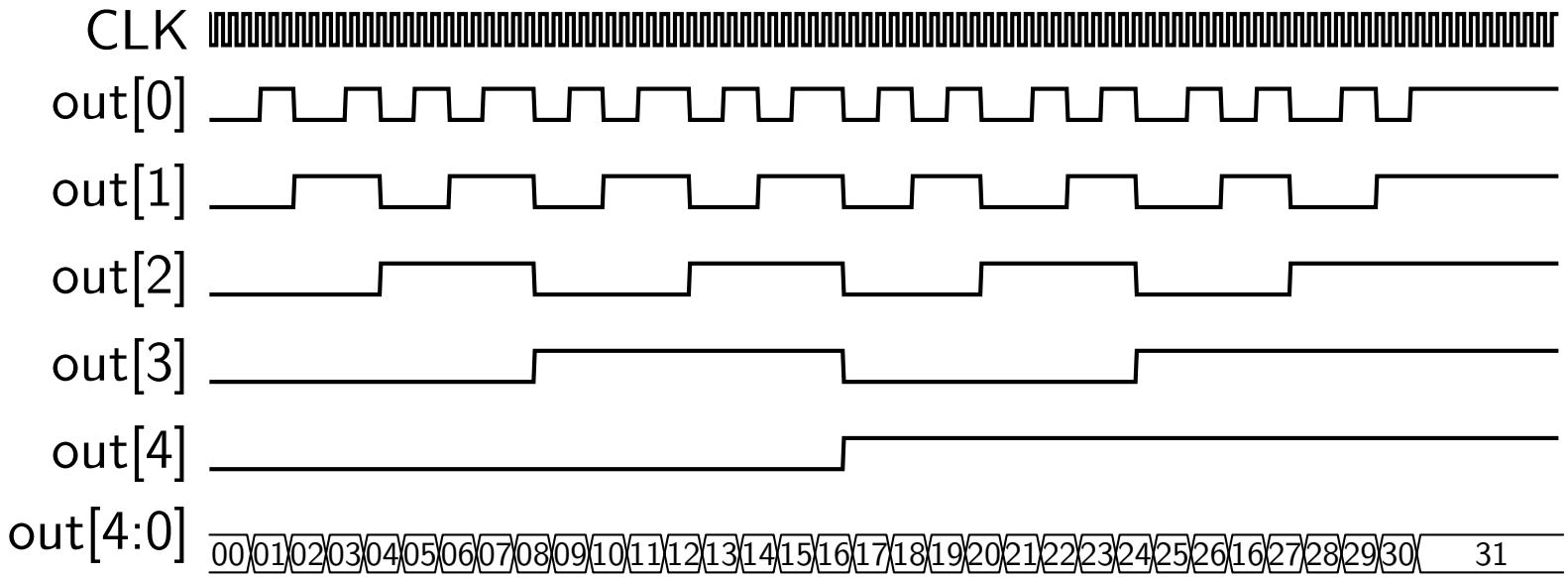




Simulations II

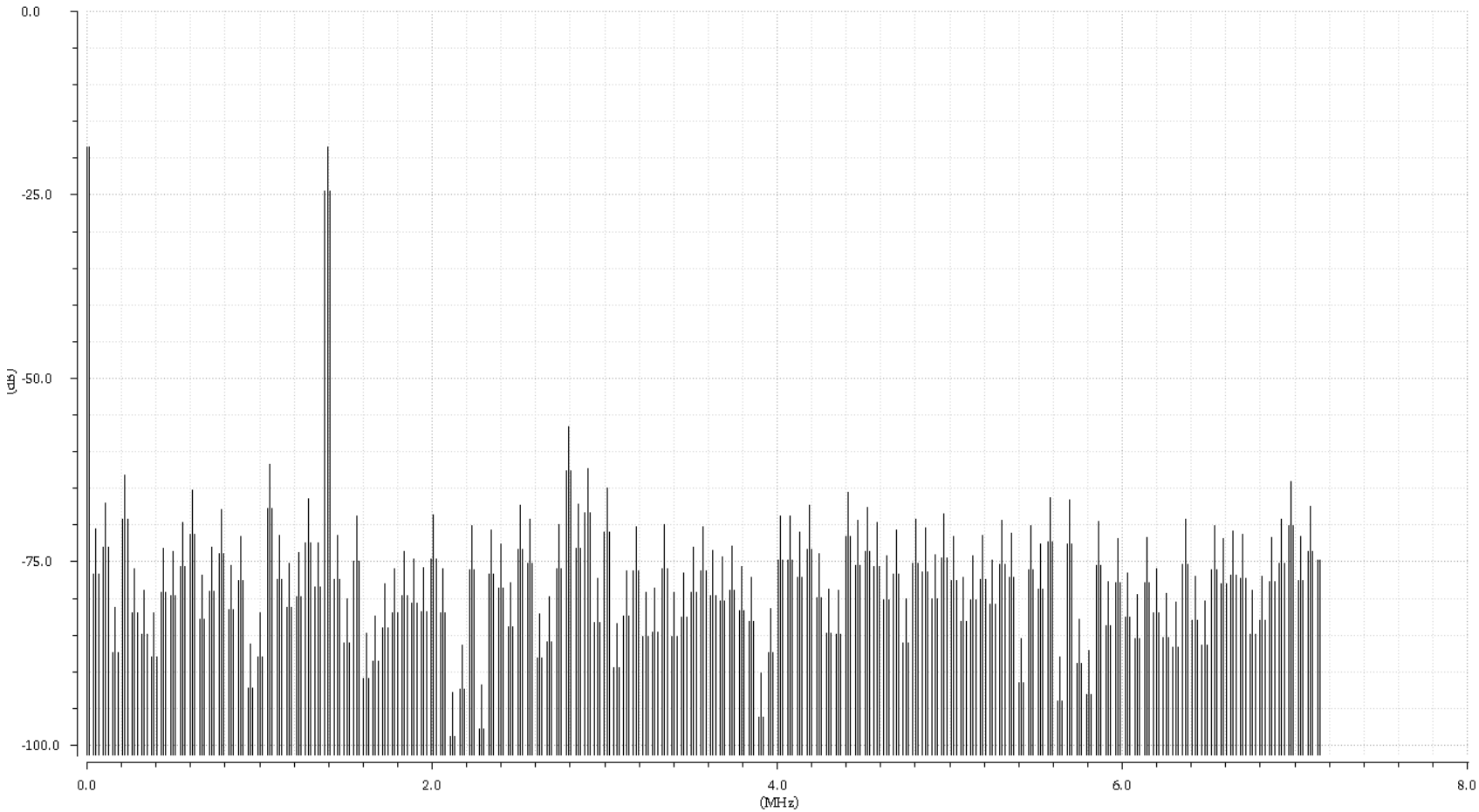
Ramp Stimulus





Simulations III

Spectrum



Figures of Merit

Sample rate	14.29 MHz
ENOB	4.78
SNDR	30.55 dB
SFDR	38.16 dB
THD	1.44 %
INL	10.22 mV
DNL	8.32 mV
Energy per cycle	4.31 pJ

References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